

PIN NAME

#	NAME	#	NAME	#	NAME	#	NAME
1	Vss	43	Vss	85	Vss	127	Vss
2	DQ0	44	OE2	86	DQ32	128	NC
3	DQ1	45	RAS2	87	DQ33	129	NC
4	DQ2	46	CAS4	88	DQ34	130	CAS5
5	DQ3	47	CAS6	89	DQ35	131	CAS7
6	Vcc	48	WE2	90	Vcc	132	PDE
7	DQ4	49	Vcc	91	DQ36	133	Vcc
8	DQ5	50	NC	92	DQ37	134	NC
9	DQ6	51	NC	93	DQ38	135	NC
10	DQ7	52	DQ16	94	DQ39	136	DQ48
11	NC	53	DQ17	95	NC	137	DQ49
12	Vss	54	Vss	96	Vss	138	Vss
13	DQ8	55	DQ18	97	DQ40	139	DQ50
14	DQ9	56	DQ19	98	DQ41	140	DQ51
15	DQ10	57	DQ20	99	DQ42	141	DQ52
16	DQ11	58	DQ21	100	DQ43	142	DQ53
17	DQ12	59	Vcc	101	DQ44	143	Vcc
18	Vcc	60	DQ22	102	Vcc	144	DQ54
19	DQ13	61	NC	103	DQ45	145	NC
20	DQ14	62	NC	104	DQ46	146	NC
21	DQ15	63	NC	105	DQ47	147	NC
22	NC	64	NC	106	NC	148	NC
23	Vss	65	DQ23	107	Vss	149	DQ55
24	NC	66	NC	108	NC	150	NC
25	NC	67	DQ24	109	NC	151	DQ56
26	Vcc	68	Vss	110	Vcc	152	Vss
27	WE0	69	DQ25	111	NC	153	DQ57
28	CAS0	70	DQ26	112	CAS1	154	DQ58
29	CAS2	71	DQ27	113	CAS3	155	DQ59
30	RAS0	72	DQ28	114	NC	156	DQ60
31	OE0	73	Vcc	115	NC	157	Vcc
32	Vss	74	DQ29	116	Vss	158	DQ61
33	A0	75	DQ30	117	A1	159	DQ62
34	A2	76	DQ31	118	A3	160	DQ63
35	A4	77	NC	119	A5	161	NC
36	A6	78	Vss	120	A7	162	Vss
37	A8	79	PD1	121	A9	163	PD2
38	A10	80	PD3	122	A11	164	PD4
39	NC	81	PD5	123	NC	165	PD6
40	Vcc	82	PD7	124	Vcc	166	PD8
41	NC	83	ID0(Vss)	125	NC	167	ID1
42	NC	84	Vcc	126	B0	168	Vcc

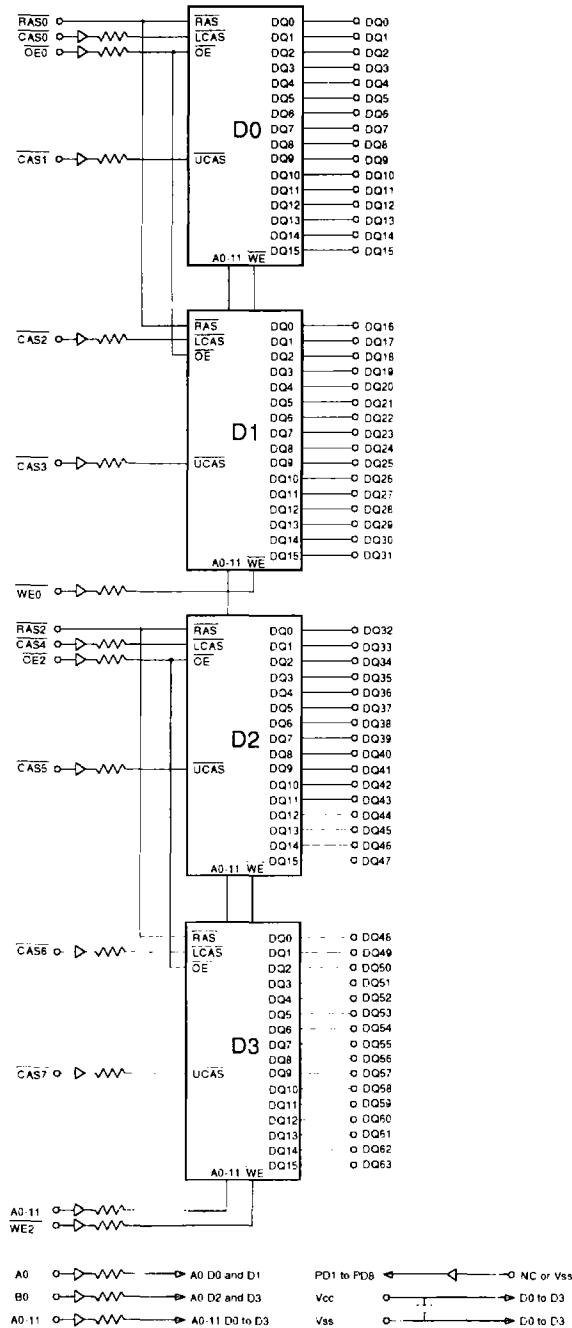
PRESENCE DETECT PINS

PIN	PD1	PD2	PD3	PD4	PD5	PD6	PD7	PD8	ID0	ID1
-70	Vss	NC	NC	Vss	Vss	Vss	NC	NC	Vss	Vss or NC
-80	Vss	NC	NC	Vss	Vss	NC	Vss	NC	Vss	Vss or NC

NOTE :

1. PDs are either open NC or driven to Vss via on-board buffer circuits.
2. IDs are connected directly to NC or Vss without a buffer.
3. ID1 will be either open NC for Self-Refresh or driven to Vss for standard.

BLOCK DIAGRAM



NOTE : All resistors are 25 Ohm± 5%

ABSOLUTE MAXIMUM RATINGS

SYMBOL	PARAMETER	RATING	UNIT
TA	Ambient Temperature	0 to 70	°C
TSTG	Storage Temperature	-55 to 150	°C
VIN, VOUT	Voltage on Any Pin Relative to Vss	-1.0 to 7.0	V
VCC	Voltage on Vcc Relative to Vss	-1.0 to 7.0	V
Ios	Short Circuit Output Current	50	mA
PD	Power Dissipation	5.3	W

NOTE : Operation at or above Absolute Maximum Ratings can adversely affect device reliability.

RECOMMENDED DC OPERATING CONDITIONS

(TA= 0°C to 70°C)

SYMBOL	PARAMETER	MIN.	TYP.	MAX.	UNIT
VCC	Supply Voltage	4.5	5.0	5.5	V
VIH	Input High Voltage	2.4	-	VCC+ 1.0	V
VIL	Input Low Voltage	-1.0	-	0.8	V

NOTE : All voltages are referenced to Vss.

DC CHARACTERISTICS

(TA= 0°C to 70°C, VCC= 5V± 10%, VSS= 0V, unless otherwise noted.)

SYMBOL	PARAMETER	TEST CONDITIONS	SPEED/ POWER	MIN.	MAX.	UNIT	NOTE
ILI	Input Leakage Current (Any Input Pin)	VSS ≤ VIN ≤ VCC+ 1.0, other pins not under test= VSS	All but RAS RAS	-10 -20	10 20	μA	
ILO	Output Leakage Current (High Impedance State)	VSS ≤ VOUT ≤ VCC, RAS & CAS at VIH		-10	10	μA	
ICC1	VCC Supply Current, Operating	tRC= tRC (min.)	70 80	- -	494 454	mA	1,2,3
ICC2	VCC Supply Current, TTL Standby	RAS & CAS at VIH, other inputs ≥ VSS		-	13	mA	
ICC3	VCC Supply Current, RAS-only refresh	tRC= tRC (min.)	70 80	- -	494 454	mA	1,3
ICC4	VCC Supply Current, Fast Page mode	tPC= tPC (min.)	70 80	- -	494 454	mA	1,2,3
ICC5	VCC Supply Current, CMOS Standby	RAS & CAS ≥ VCC-0.2V	SL-part	-	9 5.8	mA	
ICC6	VCC Supply Current, CAS-before-RAS refresh	tRC= tRC (min.)	70 80	- -	494 454	mA	1,3
ICC7	VCC Supply Current, Battery Back Up (SL-part only)	tRC= 62.5μs CAS= CBR cycling or 0.2V. WE= VCC - 0.2V, A0-A11= VCC- 0.2V or 0.2V DQ0-DQ63= VCC 0.2V, 0.2V or open	tRAS ≤ 300ns tRAS ≤ 1μs	- -	6.8 7.4	mA	1,4,5
ICC8	VCC Supply Current, Self-Refresh (SL-part only)	RAS & CAS ≤ 0.2V other pins same as ICC7		-	7.0	mA	5
VOL	Output Low Voltage	IOL= 4.2mA		-	0.4	V	
VOH	Output High Voltage	IOH= -5mA		2.4	-	V	

NOTE :

1. ICC1, ICC3, ICC4, ICC6 and ICC7 depend on cycle rate.
2. ICC1, ICC3, ICC4, and ICC6 depend on output loading. Specified values are obtained with the output open.
3. ICC is specified as average current. For ICC1, ICC3 and ICC6, address can be changed maximum two times while RAS= ViL. For ICC4, address can be changed maximum once while CAS= ViH.
4. tRAS(max.)= 1μs only applied to refresh of battery backup but tRAS(max.)= 10μs is applied to normal functional operating.
5. ICC5 (max.)= 5.8mA. ICC7 and ICC8 are applied to SL-part only (HYM564100SLXG).

AC CHARACTERISTICS

(TA= 0°C to 70°C, VCC= 5V± 10%, VSS= 0V, unless otherwise noted.) NOTE : 1, 2, 3

#	SYMBOL	PARAMETER	HYM564100 X-Series				UNIT	NOTE
			-70		-80			
			MIN.	MAX.	MIN.	MAX.		
1	tRC	Random Read or Write Cycle Time	130	-	150	-	ns	
2	tRWC	Read-Modify-Write Cycle Time	193	-	213	-	ns	14,15
3	tPC	Fast Page Mode Cycle Time	45	-	50	-	ns	
4	tPRWC	Fast Page Mode Read-Modify-Write Cycle Time	103	-	108	-	ns	13,15
5	tRAC	Access Time from $\overline{\text{RAS}}$	-	70	-	80	ns	4,9,10
6	tCAC	Access Time from $\overline{\text{CAS}}$	-	25	-	25	ns	4,9,15
7	tAA	Access Time from Column Address	-	41	-	46	ns	4,10,15
8	tCPA	Access Time from $\overline{\text{CAS}}$ Precharge	-	45	-	50	ns	4,15
9	tCLZ	$\overline{\text{CAS}}$ to Output Low Impedance	2	-	2	-	ns	4,13
10	tOFF	Output Buffer Turn-off Delay	0	20	0	20	ns	5,17
11	tT	Transition Time (Rise and Fall)	3	50	3	50	ns	3,12
12	tRP	$\overline{\text{RAS}}$ Precharge Time	50	-	60	-	ns	
13	tRAS	$\overline{\text{RAS}}$ Pulse Width	70	10K	80	10K	ns	
14	tRASp	$\overline{\text{RAS}}$ Pulse Width (Fast Page Mode)	70	100K	80	100K	ns	
15	tRSH	$\overline{\text{RAS}}$ Hold Time	25	-	25	-	ns	15
16	tCSH	$\overline{\text{CAS}}$ Hold Time	68	-	78	-	ns	14
17	tCAS	$\overline{\text{CAS}}$ Pulse Width	20	10K	20	10K	ns	
18	tRCD	$\overline{\text{RAS}}$ to $\overline{\text{CAS}}$ Delay	18	45	18	55	ns	9,16
19	tRAD	$\overline{\text{RAS}}$ to Column Address Delay Time	13	29	13	34	ns	10,16
20	tCRP	$\overline{\text{CAS}}$ to $\overline{\text{RAS}}$ Precharge Time	15	-	15	-	ns	15
21	tCP	$\overline{\text{CAS}}$ Precharge Time	10	-	10	-	ns	
22	tASR	Row Address Set-up Time	6	-	6	-	ns	15
23	tRAH	Row Address Hold Time	8	-	8	-	ns	14
24	tASC	Column Address Set-up Time	2	-	2	-	ns	13
25	tCAH	Column Address Hold Time	17	-	17	-	ns	13
26	tAR	Column Address Hold Time from $\overline{\text{RAS}}$	53	-	58	-	ns	14
27	tRAL	Column Address to $\overline{\text{RAS}}$ Lead Time	41	-	46	-	ns	15
28	tRCS	Read Command Set-up Time	2	-	2	-	ns	13
29	tRCH	Read Command Hold Time Referenced to $\overline{\text{CAS}}$	2	-	2	-	ns	6,13
30	tRRH	Read Command Hold Time Referenced to $\overline{\text{RAS}}$	-2	-	-2	-	ns	6,14
31	tWCH	Write Command Hold Time	17	-	17	-	ns	13
32	tWCR	Write Command Hold Time from $\overline{\text{RAS}}$	53	-	58	-	ns	14
33	tWP	Write Command Pulse Width	15	-	15	-	ns	
34	tRWL	Write Command to $\overline{\text{RAS}}$ Lead Time	25	-	25	-	ns	15
35	tCWL	Write Command to $\overline{\text{CAS}}$ Lead Time	22	-	22	-	ns	13
36	tDS	Data-In Set-up Time	-2	-	-2	-	ns	7,14
37	tDH	Data-In Hold Time	20	-	20	-	ns	7,15
38	tDHR	Data-In Hold Time Referenced to $\overline{\text{RAS}}$	53	-	58	-	ns	14
39	tREF	Refresh Period (4096 cycles)	-	64	-	64	ms	
		SL-part	-	256	-	256		
40	twCS	Write Command Set-up Time	2	-	2	-	ns	8,13

AC CHARACTERISTICS

(continued)

#	SYMBOL	PARAMETER	HYM564100 X-Series				UNIT	NOTE
			-70		-80			
			MIN.	MAX.	MIN.	MAX.		
41	tCWD	CAS to WE Delay Time	60	-	60	-	ns	8,15
42	tRWD	RAS to WE Delay Time	103	-	113	-	ns	8,14,15
43	tAWD	Column Address to WE Delay Time	74	-	79	-	ns	8,14,15
44	tCSR	CAS Set-up Time (CBR Cycle)	15	-	15	-	ns	15
45	tCHR	CAS Hold Time (CBR Cycle)	13	-	13	-	ns	14
46	tRPC	RAS to CAS Precharge Time	3	-	3	-	ns	14
47	tCPT	CAS Precharge Time (CBR Counter Test)	40	-	40	-	ns	
48	tROH	RAS Hold Time Referenced to OE	25	-	25	-	ns	15
49	tOEA	OE Access Time	-	25	-	25	ns	15
50	tOED	OE to Data Delay	25	-	25	-	ns	15
51	tO EZ	Output Buffer Turn Off Delay Time from OE	2	20	2	20	ns	5,17
52	tOEH	OE Command Hold Time	20	-	20	-	ns	
53	tCPWD	WE Delay Time from CAS Precharge	78	-	83	-	ns	8,14,15
54	tRHCP	RAS Hold Time from CAS Precharge	47	-	47	-	ns	13
55	tPD	PDE to Valid Presence Detect Data	-	10	-	10	ns	11
56	tPDOFF	PDE Inactive to Presence Detects Inactive	2	-	2	-	ns	12

NOTE :

1. An initial pause of 200µs is required after power-up followed by 8 RAS cycles before proper device operation is achieved. In case of using internal refresh counter, a minimum of 8 CAS-before-RAS initialization cycles instead of 8 RAS-only refresh cycles are required. The device should be carefully initialized to be prevented from being entered into multi bit test mode.
2. If RAS= Vss during power-up, the HYM564100 could begin an active cycle. This condition results in higher power-up current than necessary demands from the power-up. It is recommended that RAS and CAS track with VCC during power-up or be held at a valid VIH in order to minimize the power-up current.
3. Refer to the HY5116160 data sheet for detailed information.
4. Measured with a load equivalent to 2 TTL loads and 100pF.
5. toFF(max.) defines the time at which the output achieves the open circuit condition and is not referenced to output voltage levels
6. Either trCH or trRH must be satisfied for a read cycle
7. These parameters are referenced to CAS leading edge in early write cycles.
8. twCS is not a restrictive operating parameter. It is included in the data sheet as electrical characteristics only. If twCS ≥ twCS(min.), the cycle is an early write cycle and data out pin will remain open circuit (high impedance) through the entire cycle.
9. Operation within the trCD(max.) limit insures that trAQ(max.) can be met. trCD(max.) is specified as a reference point only. If trCD is greater than the specified trCD(max.) limit, then access time is controlled by tCAC.
10. Operation within the trAD(max.) limit insures that trAQ(max.) can be met. trAD(max.) is specified as a reference point only. If trAD is greater than the specified trAD(max.) limit, then access time is controlled by tAA.
11. Measured with the specified current load and 100pF.
12. tPDOFF(max.) is determined by the pull-up resistor value. Care must be taken to ensure adequate recovery time prior to reading valid up-level on subsequent SIMM position.
13. A + 2ns timing skew from the DRAM to the DIMM resulted from the addition of buffers (DRAM loading may add to skew).
14. A -2ns timing skew from the DRAM to the DIMM resulted from the addition of buffers (DRAM loading may add to skew).
15. A + 5ns (CAS, WE, OE) or + 6ns (address) timing skew from the DRAM to the DIMM resulted from the addition of buffers. (DRAM loading may add skew).
16. A -2ns min and a -5ns (CAS, WE, OE) or -6ns (address) max timing skew from the DRAM to the DIMM resulted from the addition of buffers. (DRAM loading may add to skew).
17. A + 2ns min and a + 5ns (CAS, WE, OE) or + 6ns (address) max timing skew from the DRAM to the DIMM resulted from the addition of buffers. (DRAM loading may add to skew).
18. A burst of 4096 CAS-before-RAS refresh cycles must be executed within 64ms (256ms for SL-part) after exiting self refresh.

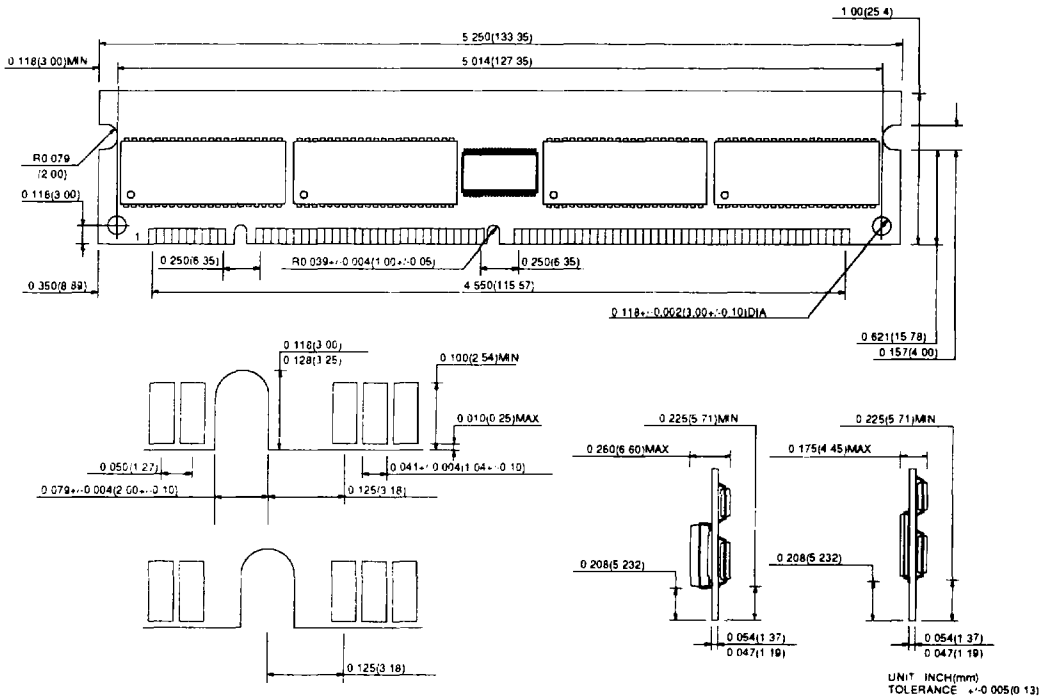
CAPACITANCE

(TA= 25°C, VCC= 5V± 10%, VSS= 0V, f= 1MHz, unless otherwise noted.)

SYMBOL	PARAMETER	TYP.	MAX.	UNIT
CIN1	Input Capacitance (A0-A11,B0)	-	20	pF
CIN2	Input Capacitance (RAS0,RAS2)	-	20	pF
CIN3	Input Capacitance (CAS0-CAS7,WE0,WE2,OE0,OE2)	-	20	pF
CDQ	Data Input/Output Capacitance (DQ0-DQ63)	-	20	pF

PACKAGE INFORMATION

168 pin Dual In-line Memory Module (XG ; Gold plated)



ORDERING INFORMATION

PART NUMBER	SPEED	POWER	PACKAGE	PLATING
HYM564100XG	70/80		DIMM	Gold
HYM564100SLXG	70/80	SL-part	DIMM	Gold